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*Altman, E.R.; Ebcioğlu, K.; Gschwind, M.; Sathaye, S.;*  
Proceedings of the IEEE , Volume: 89 , Issue: 11 , Nov. 2001  
Pages:1710 - 1722

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<i>DB=USPT; PLUR=YES; OP=ADJ</i>			
<u>L22</u>	L19 and (guest\$ or host\$ ) near5 translat\$	1	<u>L22</u>
<u>L21</u>	L19 and (guest\$ and host\$ and activ\$)	0	<u>L21</u>
<u>L20</u>	L19 and guest and data structure	1	<u>L20</u>
<u>L19</u>	5555385.pn.	1	<u>L19</u>
<u>L18</u>	L17 and l12	4	<u>L18</u>
<u>L17</u>	711/6,202,203,204,206,207,209.ccls.	2152	<u>L17</u>
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<u>L15</u>	717/136,138,139,140.ccls.	454	<u>L15</u>
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<u>L11</u>	L10 and (active near5 translat\$)	2	<u>L11</u>
<i>DB=USPT,TDBD; PLUR=YES; OP=ADJ</i>			

<u>L10</u>	L9 and translat\$ near5 (data structure\$)	52	<u>L10</u>
<u>L9</u>	(transtal\$ or convert\$ or compil\$) and virtual machin\$ and (operating system)	1546	<u>L9</u>
<i>DB=USPT; PLUR=YES; OP=ADJ</i>			
<u>L8</u>	(transtal\$ or convert\$ or compil\$) and virtual machin\$ and operting system	1	<u>L8</u>
<i>DB=TDBD; PLUR=YES; OP=ADJ</i>			
<u>L7</u>	L4	0	<u>L7</u>
<i>DB=DWPI; PLUR=YES; OP=ADJ</i>			
<u>L6</u>	L4	0	<u>L6</u>
<i>DB=JPAB; PLUR=YES; OP=ADJ</i>			
<u>L5</u>	L4	0	<u>L5</u>
<i>DB=EPAB; PLUR=YES; OP=ADJ</i>			
<u>L4</u>	(ACTIVE translat\$ and guest translat\$) and virtual machine	0	<u>L4</u>
<i>DB=USOC; PLUR=YES; OP=ADJ</i>			
<u>L3</u>	(ACTIVE translat\$ and guest translat\$) and virtual machine	0	<u>L3</u>
<i>DB=PGPB; PLUR=YES; OP=ADJ</i>			
<u>L2</u>	(ACTIVE translat\$ and guest translat\$) and virtual machine	1	<u>L2</u>
<i>DB=USPT; PLUR=YES; OP=ADJ</i>			
<u>L1</u>	(ACTIVE translat\$ and guest translat\$) and virtual machine	0	<u>L1</u>

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